## Search Notes



602

Application/Control No.	Applicant(s)/Patent Under Reexamination
10710855	CHANG, SUNG-SAN
Examiner	Art Unit
Heyi, Henok G	2609

Henok heyi

SEARCHED						
Class	Subclass	Date	Examiner			
369	30.27	03/04/2008	Henok heyi			
	53.25	03/04/2008	Henok heyi			
720	600	03/04/2008	Henok heyi			
	601	03/04/2008	Henok heyi			

SEARCH NOTES				
Search Notes	Date	Examiner		
Conducted both classified and text search using EAST. I have also used google patents. I got help in search, claim interpretation and analysis from the class assistant trainer, Krista. I also asked a primary examiner, Tan Dinh, to direct me to the right classification of this application because it was not properly classifed.	06/21/2007	Henok Heyi		
Updated search. Also conducted an interference search.	03/04/2008	Henok Heyi		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

U.S. Patent and Trademark Office Part of Paper No.: 20080304